Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/524,444	Reexamination MOCHIZUKI ET A	AL.
Examiner	Art Unit	
HENOK G. HEYI	2627	Page 1 of 1

U.S. PATENT DOCUMENTS

	C.S. I ATEN DOCUMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,002,834 A	12-1999	Hirabayashi et al.	386/70
*	В	US-2003/0126390 A1	07-2003	Huang, Hui-Chieh	711/163
	υ	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-		-	
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000276851 A	10-2000	Japan	KANAI, HIROFUMI	G11B 20/10
	0					
	Р					
	Q					
	R					
	s					
	т					

NON DATENT DOCUMENTS

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	
	v	
	w	
	x	

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.